

# FAIRCHILD

SEMICONDUCTOR®

September 2010

# FDMS2510SDC

# N-Channel Dual Cool<sup>TM</sup> PowerTrench<sup>®</sup> SyncFET<sup>TM</sup> 25 V, 49 A, 2.9 m $\Omega$

### **Features**

- Dual Cool<sup>TM</sup> Top Side Cooling PQFN package
- Max  $r_{DS(on)} = 2.9 \text{ m}\Omega$  at  $V_{GS} = 10 \text{ V}$ ,  $I_D = 23 \text{ A}$
- Max  $r_{DS(on)} = 4.2 \text{ m}\Omega$  at  $V_{GS} = 4.5 \text{ V}$ ,  $I_D = 18 \text{ A}$
- High performance technology for extremely low r<sub>DS(on)</sub>
- SyncFET Schottky Body Diode
- RoHS Compliant

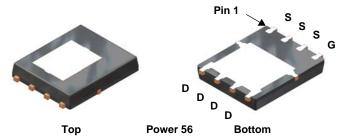


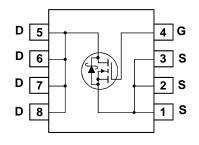
### **General Description**

This N-Channel MOSFET is produced using Fairchild Semiconductor's advanced PowerTrench® process. Advancements in both silicon and Dual  $\text{Cool}^{\text{TM}}$  package technologies have been combined to offer the lowest  $r_{\text{DS(on)}}$  while maintaining excellent switching performance by extremely low Junction-to-Ambient thermal resistance. This device has the added benefit of an efficient monolithic Schottky body diode.

### **Applications**

- Synchronous Rectifier for DC/DC Converters
- Telecom Secondary Side Rectification
- High End Server/Workstation Vcore Low Side





## **MOSFET Maximum Ratings** T<sub>A</sub> = 25°C unless otherwise noted

Symbol	Parameter			Ratings	Units
V <sub>DS</sub>	Drain to Source Voltage			25	V
$V_{GS}$	Gate to Source Voltage		(Note 4)	±20	V
	Drain Current -Continuous (Package limited)	T <sub>C</sub> = 25 °C		49	
	-Continuous (Silicon limited)	T <sub>C</sub> = 25 °C		117	A
'D	-Continuous	T <sub>A</sub> = 25 °C	(Note 1a)	28	1 ^
	-Pulsed			200	
E <sub>AS</sub>	Single Pulse Avalanche Energy		(Note 3)	84	mJ
dv/dt	Peak Diode Recovery dv/dt		(Note 5)	2.5	V/ns
В	Power Dissipation	T <sub>C</sub> = 25 °C		60	w
$P_{D}$	Power Dissipation	T <sub>A</sub> = 25 °C	(Note 1a)	3.3	- vv
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temperature Ra	ange		-55 to +150	°C

### **Thermal Characteristics**

$R_{\theta JC}$	Thermal Resistance, Junction to Case	(Top Source)	4.4	
$R_{\theta JC}$	Thermal Resistance, Junction to Case	(Bottom Drain)	2.1	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1a)	38	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1b)	81	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1i)	16	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1j)	23	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1k)	11	

### **Package Marking and Ordering Information**

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
2510S	FDMS2510SDC	Dual Cool <sup>TM</sup> Power 56	13"	12 mm	3000 units

# 查询"FDMS2510SDC"供应商 Electrical Characteristics $T_J = 25 \, ^{\circ}\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Chara	cteristics					
BV <sub>DSS</sub>	Drain to Source Breakdown Voltage	I <sub>D</sub> = 1 mA, V <sub>GS</sub> = 0 V	25			V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	I <sub>D</sub> = 10 mA, referenced to 25 °C		19		mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 20 V, V <sub>GS</sub> = 0 V			500	μΑ
I <sub>GSS</sub>	Gate to Source Leakage Current, Forward	V <sub>GS</sub> = 20 V, V <sub>DS</sub> = 0 V			100	nA

### **On Characteristics**

$V_{GS(th)}$	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}$ , $I_D = 1 \text{ mA}$	1.2	1.7	3.0	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I <sub>D</sub> = 10 mA, referenced to 25 °C		-5		mV/°C
		V <sub>GS</sub> = 10 V, I <sub>D</sub> = 23 A		2.4	2.9	
r <sub>DS(on)</sub>	Static Drain to Source On Resistance	$V_{GS} = 4.5 \text{ V}, I_D = 18 \text{ A}$		3.4	4.2	mΩ
		$V_{GS} = 10 \text{ V}, I_D = 23 \text{ A}, T_J = 125 \text{ °C}$		3.5	4.3	
9 <sub>FS</sub>	Forward Transconductance	V <sub>DS</sub> = 5 V, I <sub>D</sub> = 23 A		159		S

## **Dynamic Characteristics**

C <sub>iss</sub>	Input Capacitance	V 42.V V 0.V	2090	2780	pF
C <sub>oss</sub>	Output Capacitance	$V_{DS} = 13 \text{ V}, V_{GS} = 0 \text{ V},$ $f = 1 \text{ MHz}$	577	770	рF
C <sub>rss</sub>	Reverse Transfer Capacitance	1 - 1 1/11/12	128	195	pF
$R_g$	Gate Resistance		1.1	2.4	Ω

## **Switching Characteristics**

t <sub>d(on)</sub>	Turn-On Delay Time		10	20	ns
t <sub>r</sub>	Rise Time	V <sub>DD</sub> = 13 V, I <sub>D</sub> = 23 A,	4	10	ns
t <sub>d(off)</sub>	Turn-Off Delay Time	$V_{GS} = 10 \text{ V}, R_{GEN} = 6 \Omega$	27	43	ns
t <sub>f</sub>	Fall Time		3	10	ns
$Q_g$	Total Gate Charge	V <sub>GS</sub> = 0 V to 10 V	32	45	nC
$Q_g$	Total Gate Charge	$V_{GS} = 0 \text{ V to } 4.5 \text{ V} V_{DD} = 13 \text{ V},$	15	21	nC
Q <sub>gs</sub>	Gate to Source Gate Charge	I <sub>D</sub> = 23 A	6.3		nC
$Q_{gd}$	Gate to Drain "Miller" Charge		4.0		nC

### **Drain-Source Diode Characteristics**

V Source	Source to Drain Diode Forward Voltage	$V_{GS} = 0 V, I_S = 2 A$ (Note 2)	0.48	0.8	\/
$v_{SD}$	Source to Drain Diode Porward voltage	$V_{GS} = 0 \text{ V}, I_S = 23 \text{ A}$ (Note 2)	0.79	1.2	V
t <sub>rr</sub>	Reverse Recovery Time	I <sub>F</sub> = 23 A, di/dt = 300 A/ μs	23	36	ns
Q <sub>rr</sub>	Reverse Recovery Charge	- I <sub>F</sub> = 23 A, di/dt = 300 A/ μs		31	nC

### **Thermal Characteristics**

$R_{\theta JC}$	Thermal Resistance, Junction to Case	(Top Source)	4.4	
$R_{\theta JC}$	Thermal Resistance, Junction to Case	(Bottom Drain)	2.1	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1a)	38	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1b)	81	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1c)	27	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1d)	34	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1e)	16	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1f)	19	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1g)	26	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1h)	61	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1i)	16	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1j)	23	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1k)	11	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1I)	13	

#### NOTES

1. R<sub>0JA</sub> is determined with the device mounted on specified pad 2 oz copper pad on board of FR-4 material. R<sub>0JC</sub> is guaranteed by design while R<sub>0CA</sub> is determined by the user's board design.



a. 38 °C/W when mounted on a 1 in<sup>2</sup> pad of 2 oz copper



b. 81 °C/W when mounted on a minimum pad of 2 oz copper

- c. Still air, 20.9x10.4x12.7mm Aluminum Heat Sink, 1 in<sup>2</sup> pad of 2 oz copper
- d. Still air, 20.9x10.4x12.7mm Aluminum Heat Sink, minimum pad of 2 oz copper
- e. Still air, 45.2x41.4x11.7mm Aavid Thermalloy Part # 10-L41B-11 Heat Sink, 1 in<sup>2</sup> pad of 2 oz copper
- f. Still air, 45.2x41.4x11.7mm Aavid Thermalloy Part # 10-L41B-11 Heat Sink, minimum pad of 2 oz copper
- g. 200FPM Airflow, No Heat Sink,1 in<sup>2</sup> pad of 2 oz copper
- h. 200FPM Airflow, No Heat Sink, minimum pad of 2 oz copper
- i. 200FPM Airflow, 20.9x10.4x12.7mm Aluminum Heat Sink, 1 in  $^2$  pad of 2 oz copper
- j. 200FPM Airflow, 20.9x10.4x12.7mm Aluminum Heat Sink, minimum pad of 2 oz copper
- k. 200FPM Airflow, 45.2x41.4x11.7mm Aavid Thermalloy Part # 10-L41B-11 Heat Sink, 1 in<sup>2</sup> pad of 2 oz copper
- $I.\ 200 FPM\ Airflow,\ 45.2x41.4x11.7mm\ Aavid\ Thermalloy\ Part\ \#\ 10-L41B-11\ Heat\ Sink,\ minimum\ pad\ of\ 2\ oz\ copper$
- 2. Pulse Test: Pulse Width < 300  $\mu$ s, Duty cycle < 2.0%.
- 3.  $E_{AS}$  of 84 mJ is based on starting  $T_J$  = 25 °C, L = 1 mH,  $I_{AS}$  = 13 A,  $V_{DD}$  = 23 V,  $V_{GS}$  = 10 V. 100% test at L = 0.3 mH,  $I_{AS}$  = 20 A.
- 4. As an N-ch device, the negative Vgs rating is for low duty cycle pulse ocurrence only. No continuous rating is implied.
- 5. I  $_{SD} \leq 23$  A, di/dt  $\leq 200$  A/µs, V  $_{DD} \leq$  BV  $_{DSS}$ , Starting T  $_{J}$  = 25  $^{o}C.$

# Typical Characteristics T<sub>J</sub> = 25 °C unless otherwise noted

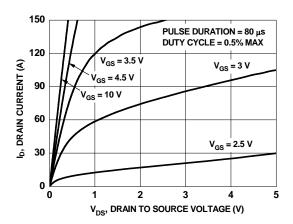


Figure 1. On Region Characteristics

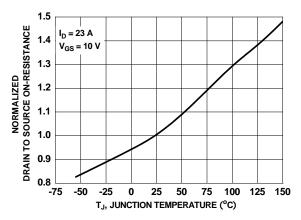


Figure 3. Normalized On Resistance vs Junction Temperature

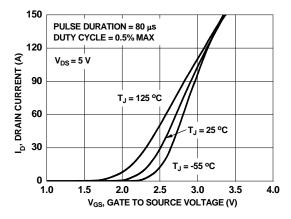


Figure 5. Transfer Characteristics

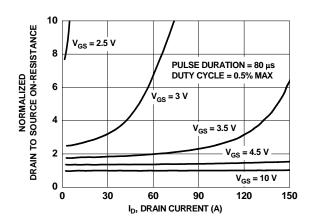


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

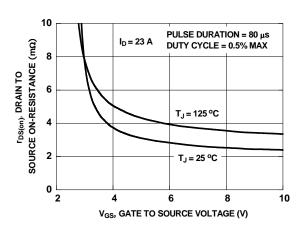


Figure 4. On-Resistance vs Gate to Source Voltage

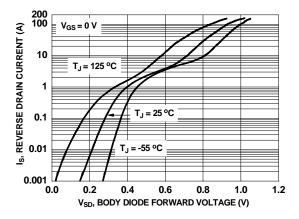


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

## Typical Characteristics T<sub>J</sub> = 25 °C unless otherwise noted

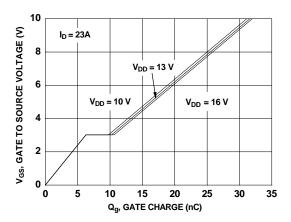


Figure 7. Gate Charge Characteristics

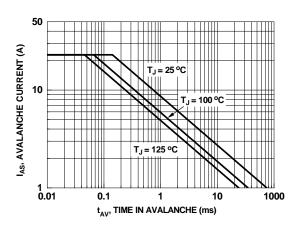


Figure 9. Unclamped Inductive Switching Capability

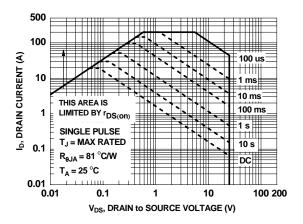


Figure 11. Forward Bias Safe Operating Area

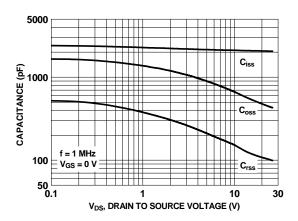


Figure 8. Capacitance vs Drain to Source Voltage

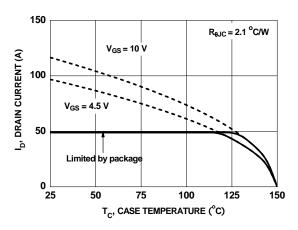


Figure 10. Maximum Continuous Drain Current vs Case Temperature

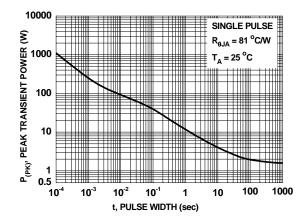


Figure 12. Single Pulse Maximum Power Dissipation

# Typical Characteristics T<sub>J</sub> = 25 °C unless otherwise noted

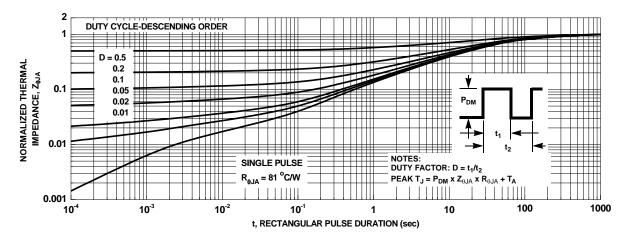


Figure 13. Junction-to-Ambient Transient Thermal Response Curve

## Typical Characteristics (continued)

# SyncFET Schottky body diode Characteristics

Fairchild's SyncFET process embeds a Schottky diode in parallel with PowerTrench MOSFET. This diode exhibits similar characteristics to a discrete external Schottky diode in parallel with a MOSFET. Figure 14 shows the reverse recovery characteristic of the FDMS2510SDC.

Schottky barrier diodes exhibit significant leakage at high temperature and high reverse voltage. This will increase the power in the device.

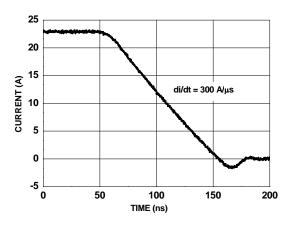


Figure 14. FDMS2510SDC SyncFET body diode reverse recovery characteristic

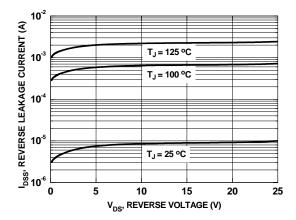
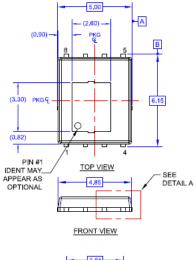
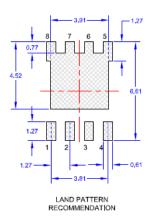
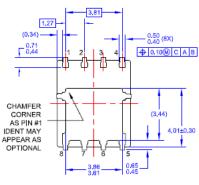


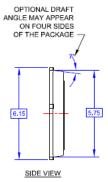
Figure 15. SyncFET body diode reverse leakage versus drain-source voltage

# **Dimensional Outline and Pad Layout**

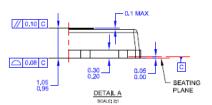












NOTES; UNLESS OTHERWISE SPECIFIED

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